Synchrotron radiation in solid state spectroscopy

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Unique spectral features and time structure of synchrotron radiation allows Onique spectral relatives and time structure of synchrotron radiation allo one to use this kind of excitation in investigation of electronic relaxation processes in insulators with wide band gap. The knowledge of these processes is important for understanding of scintillation efficiency in crystals. Luminescence excitation technique is convenient for study of energy transfer in these systems and for investigation of crystal energy structure.

In general, luminescence excitation spectra can be subdivided into several spectral regions:

- > Direct excitation of lowest defect excited state
- > Ionization of defects by photons with energy below the matrix forbidden gap
- > Excitation of matrix Urbach tail
- > Excitation of excitons
- > Production of separated low-energy electron-hole pairs
- Production of high-energy electron-hole pairs followed by impact excitation/ionization of defects

Each of these regions is characterized by different role of relaxation channels. Possible channels of energy transfer and relaxation are discussed in the presentation.



Dynamics of electronic relax ation in wide bandgap solids



Absorption coefficient in wide photon energy range and different

- > Ionization of defects by photons with energy below the matrix forbidden gap
- > Excitation of matrix Urbach tail







CTL spectra and excitation of CTL spectra of ses quio xides measured with different time windows. temperature 10 K.

Slow/fast emission ratio in creases with energy in Urbach tail region, i.e. slow component in creases with de loc al iz atio n.

Urbach tail effect in PbWO4 excitation spectra Temperature dependence of $\lg \alpha(\eta \omega)$ PWO excitation spectra 0 shows two phenomena: (1) dependence of excitation em. 40 0nm 30 K spectrum in Urbach - 150 K absorption region due to 200K ηω change of the fraction of 0.0 3.5 absorbed radiation in the 4.0 4.5 5.0 5.5 6.0 200K 30K 2.0 sam ple and 150K em. 520 nm 30K Quantum Yield a.u. 1 1 (2) increasing of the slope of 📥 1 50 K quantum yield with T in the 2.00 K region of separated e-h pairs (see below) 3.5 4.0 4.5 5.0 5.5 6.0 6.5 hv.eV

Yb³⁺ charge transfer luminescence (CTL) excitation (Guerassi mova et al)

PWO excitation spectra for blue (top) and green (bottom) emission bands

- > Excitation of matrix Urbach tail
- > Excitation of excitons
- > Production of separated low-energy electron-hole pairs



Production of separated low-energy electron-hole pairs



of the components of an electron-hole pair vs their energy The nature of this curve is the increase of election-hole separation with pair energy and the decrease of direct recombination with this separation: Separated electron and hole Coupled electron Probability of recombination = $\begin{cases} 1, & r < R_0 \\ R_0/r, & r \ge R_0 \end{cases}$ Long-decay emission and hole Short-decav emiss ion r 0.8 Probability 90 R_o increases with decrease of temperature, therefore this probability is temperature anerav dependent: $(E)=R_0$ 0.2 00 Energy of an electron-hole pair

Probability of binding or separation

Production of high-energy electron-hole pairs followed by impact excitation/ionization of defects



The effect of electron kinetic energy on the efficiency of energy transfer to the luminescence center as a function of tempera ture (Spassky et al)





ZnWO₄: (a) -quantum yield spectra at RT and LHeT and reflectivity (thin curve); (b) – the ratio of the above quantum yield spectra.

Excitation spectrum
 temperature dependence is described in previous slide





Two types of recombination channels: excitonic one (upper part) and recombination on a centre (lower part). Figures on the right display typical energy dependence of the quantum yield of the se channels







Experimentally observed two types of recombination channels

> luminescence of CaWO₄ (upper panel) [S. I. Golovkova, A. M. Gurvich, A. I. Kravchenko, V. V. Mikhailin, A. N. Vasil'ev, Phys. Stat. Sol. (a), 77 (1983) 375]

and

activator luminescence of

CaSO, : Sm [I. A. Kamenskikh, V. V. Mikhailin, I. N. Shpinkov and A. N. Vasil'ev, Nucl. Instr. and Meth., A282 (1989) 599] (middle panel)

> Mani festation of core excitons in optical functions in VUV reguion







Manifestation of core excitons in in optical functions in VUV requion

Intensity of core exciton peaks correlates with the nature of the bottom of the conduction band (Kolobanov, Spassky et al).

Cation core excitons are visible only if the lowest states of conduction band are formed from cation states (Pb and Ba molibdates).

Reflectivity shows no structure in core exciton region if the lowest states are formed from complex anion states (Sr and Ca molibdates).



Benefits of VUV and X-ray SR in radiation damage study

- VUV (especially XUV) and X-ray photons produce the same spectrum of elementary electronic excitations (electron-hole pairs, excitons, core level excitations, initial defect formation stages) as highenergy ionizing particle
- Absorption coefficient in XUV and X-ray region is extremely high (10⁴ to 10⁶ cm⁻¹), therefore accumulated dose in the thin absorption layer becomes huge
- Unique spectral features and time structure, and high intensity of synchrotron radiation allow one to use this kind of excitation in investigation of defects and their creation in insulators with wide band gap.



SR spectral distribution for various electron energy (R=32 m)

The reasons of light yield instability induced by radiation

•Creation of the reversible damage:

a) transient defects - close *F*-*H* pairsb) Change of electronic state of deep defect levels in the forbidden energy gap

•Creation of the irreversible damage:

a) stable *F*-*H* pairsb) defect conglomerates

How to study radiation effects using luminescence spectroscopy

- Changes of luminescence emission spectra (additional emission bands)
- Changes of decay kinetics (radiation defects can result in sharpening of initial stages of decay and increasing of slow component)
- Changes of energy transfer (radiation defects can change ratio of several relaxation channels)

Usage of SR in X-ray region in the study of PWO radiation hardness

•VEPP-3 (Budker INP): Flux of 10¹⁶ ph/s with energy from 2 to 100 KeV ("white" X-rays) •DCI (Lure, Orsay): Flux of 10¹² ph/s of monochromatized 15 KeV X-ray photons



Radiation damage in PWO

- Dose rate is about 1 kGy/sec (in thin absorption layer, d~ 10⁻⁵ cm)
- Degradation / enhancing of emission under irradiation depends on the emission spectral region
- Fast and slow recovering of radiation defects (upper panel)

Dose dependence for different regions of PWO emission spectrum excited by X-ray SR



- (a) Green emis sion (480 nm)

 fast de grada tion a t firs t
 sec follo we d by much
 slower de grada tion
- (b) Blue emissi on (380 nm) is more stable under irradiation

(c) Few cases of increase of emission in interme diate range (430 nm) under irradiation – the ev idence of ne w emis sion center prod uctio n

Lead Tungstate scintillators







Excitation by 90 eV photons (SuperACO)

•Dose rate is about 1 kGy/sec (in thin absorption layer, d~10 $^{-5}$ cm)

•Degradation / enhancing of emission under irradiation depends on the emission spectral region

•Fast and slow recovering of radiation defects (upper panel)

PWO emission spectrum explanation

•Fast (blue) component – excitonic (Pb) emission, (should be linear with excitation intensity)

•Slow (green) component – defect recombination emission, (should be non-linear (quadratic?) with excitation intensity)

How to measure nonlinear excitation efficiency?



Modulation of SR spectrum by the grating spectral efficiency with sharp peculiarities allows one to estimate the order of the process

Sharp structure due to Pt covering of the grating dissapiars in 1st order fast PWO emission and 2nd order slow PWO emission

Conclusions

Fundamental mechanisms of electronic relaxation in large bandgap solids and energy transfer can be studied by analysis of luminescence excitation spectra and kinetics excited by VUV-X synchrotron radiation photons, especially using Time-Resolved Luminescence VUV Spectroscopy.

High flux of SR enables to simulate and investigate radiation damage effects.